

#### N-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX T <sub>A</sub> = +25°C
	29mΩ @ V <sub>GS</sub> = 10V	6.9A
60V	34mΩ @ V <sub>GS</sub> = 6V	6.4A

## **Description and Applications**

This MOSFET is designed to minimize the on-state resistance (RDS(ON)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- **Power Management Functions**
- DC-DC Converters

# **Features and Benefits**

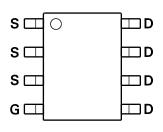
- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

#### **Mechanical Data**

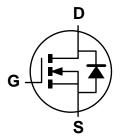
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 3 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.008 grams (Approximate)







Top View



**Equivalent Circuit** 

#### **Ordering Information** (Note 4)

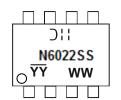
Part Number	Case	Packaging
DMN6022SSS-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## **Marking Information**

SO-8



☐ = Manufacturer's Marking N6022SS = Product Type Marking Code YYWW = Date Code Marking  $\overline{YY}$  = Year (ex: 19 = 2019) WW = Week (01 to 53)



## **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			$V_{DSS}$	60	V
Gate-Source Voltage			$V_{GSS}$	±20	V
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	6.9 5.5	А
Maximum Continuous Body Diode Forward Current (Note 6)			Is	6.9	Α
Pulsed Drain Current (10μs Pulse, Duty Cycle = 1%)			I <sub>DM</sub>	40	Α
Pulsed Source Current (10μs Pulse, Duty Cycle = 1%)			I <sub>SM</sub>	40	Α
Avalanche Current (Note 7) L = 0.1mH			I <sub>AS</sub>	22	Α
Avalanche Energy (Note 7) L = 0.1mH			E <sub>AS</sub>	36	mJ

## Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	$P_{D}$	1.3	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	98	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	P <sub>D</sub>	2.1	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	60	°C/W
Operating and Storage Temperature Range		$T_{J_i}T_{STG}$	-55 to +150	°C

# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Cumbal	Min	Tim	May	l lmi4	Toot Condition
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)			ı	1		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60			V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1	_	3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance		_	18	29	mΩ	$V_{GS} = 10V, I_D = 5A$
Static Dialif-Source Off-Resistance	R <sub>DS(ON)</sub>	_	19	34	11122	$V_{GS} = 6V, I_D = 5A$
Diode Forward Voltage	$V_{SD}$	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1.7A$
DYNAMIC CHARACTERISTICS (Note 9)	DYNAMIC CHARACTERISTICS (Note 9)					
Input Capacitance	C <sub>iss</sub>	_	2110	_	pF	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V f = 1.0MHz
Output Capacitance	Coss	_	78	_		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	51	_		
Gate Resistance	$R_g$	_	2.0	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_g$	_	14	_		
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	32	_	nC	$V_{DS} = 30V, I_D = 6A$
Gate-Source Charge	Qgs	_	7.0	_	IIC	
Gate-Drain Charge	$Q_{gd}$	_	4.0	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	5.4	_		$V_{GS}=10V,V_{DD}=30V,R_g=6\Omega,$ $I_D=1A$
Turn-On Rise Time	t <sub>R</sub>	_	4.4	_	ns	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	30.4	_	115	
Turn-Off Fall Time	t <sub>F</sub>	_	8.4	_		
Body Diode Reverse Recovery Time	t <sub>RR</sub>	_	18.1	_	ns	I <sub>S</sub> = 1.7A, dI/dt = 100A/μs
Body Diode Reverse Recovery Charge	$Q_{RR}$	_	12.5	_	nC	$I_S = 1.7A$ , $dI/dt = 100A/\mu s$

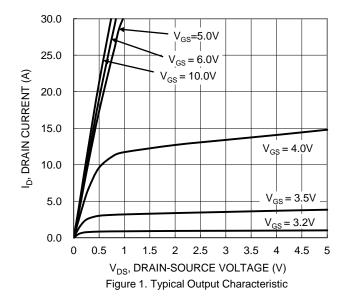
Iotes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

<sup>7.</sup>  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J = +25$ °C.

<sup>8.</sup> Short duration pulse test used to minimize self-heating effect.

<sup>9.</sup> Guaranteed by design. Not subject to product testing.





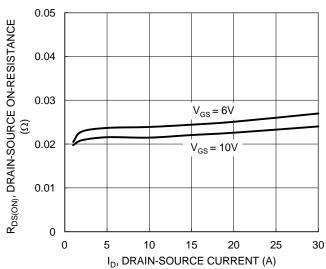


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

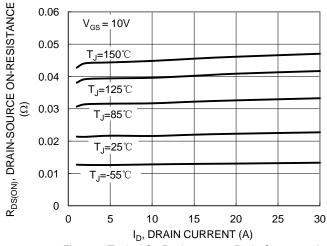
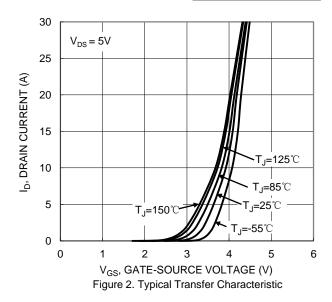
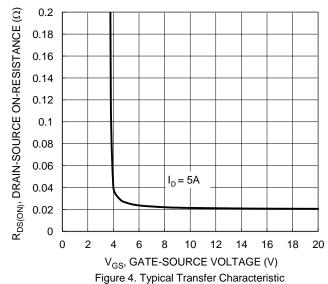


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





2.5  $V_{GS} = 10V, I_{D} = 5A$ R<sub>DS(ON)</sub>, DRAIN-SOURCE ON-RESISTANCE (NORMALIZED) 2 1.5 1  $V_{GS} = 6V, I_{D} = 5A$ 0.5 0 -50 -25 25 50 75 100 125 150  $T_J$ , JUNCTION TEMPERATURE ( $^{\circ}$ C)

Figure 6. On-Resistance Variation with Junction Temperature



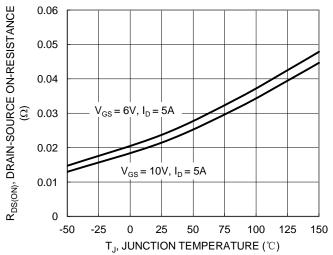
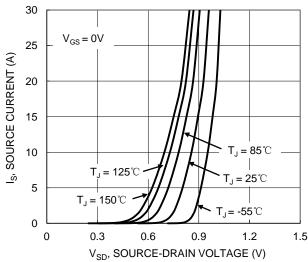


Figure 7.On-Resistance Variation with Junction Temperature



V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current

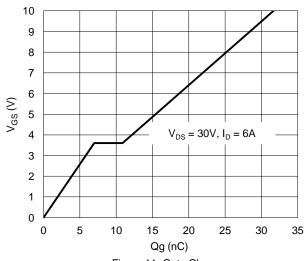


Figure 11. Gate Charge

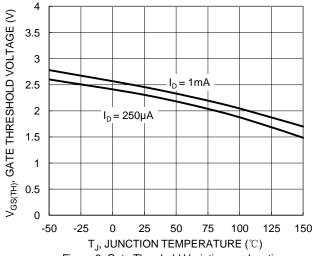
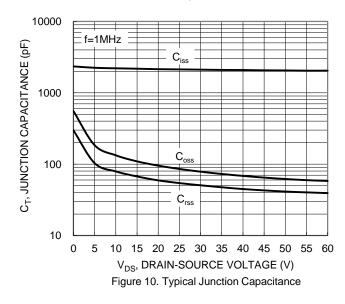


Figure 8. Gate Threshold Variation vs .Junction Temperature



100 R<sub>DS(ON)</sub> Limited 10 ID, DRAIN CURRENT (A) <sub>w</sub> =100ms  $T_{J(Max)} = 150$ °C 0.1  $T_C = 25^{\circ}C$ Single Pulse DUT on 1\*MRP Board  $V_{GS} = 10V$ 0.01 0.1 100 10 V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



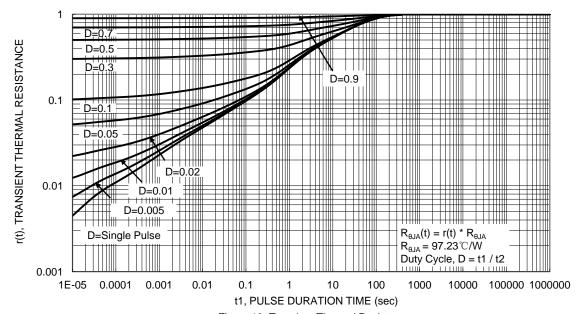


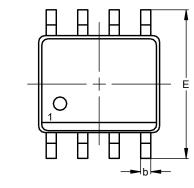
Figure 13. Transient Thermal Resistance

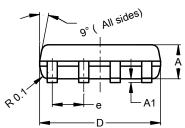


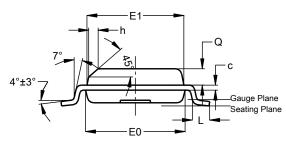
# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



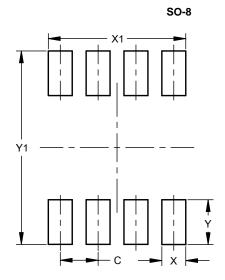




SO-8						
Dim	Min	Max	Тур			
Α	1.40	1.50	1.45			
A1	0.10	0.20	0.15			
b	0.30	0.50	0.40			
C	0.15	0.25	0.20			
D	4.85	4.95	4.90			
Е	5.90	6.10	6.00			
E1	3.80	3.90	3.85			
E0	3.85	3.95	3.90			
е			1.27			
h			0.35			
Г	0.62	0.82	0.72			
Q	0.60	0.70	0.65			
All Dimensions in mm						

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	1.27
Х	0.802
X1	4.612
Υ	1.505
Y1	6.50



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